		74AC1162 OCTAL BUS TRANSCEIVEI WITH 3-STATE OUTPUTS SCAS058A - JULY 1987 - REVISED APRIL 1987
• Loca	al Bus-Latch Capability	DW OR NT PACKAGE
 Flow 	r-Through Architecture Optimizes PCB	(TOP VIEW)
Layo	•	
 Cent 	er-Pin V _{CC} and GND Configurations	A2 2 23 B1
Mini	mize High-Speed Switching Noise	A3 🛛 3 22 🗍 B2
• EPIC	C™ (Enhanced-Performance Implanted	A4 🛛 4 21 🗋 B3
CMC	OS) 1-μm Process	GND 🛛 5 20 🛛 B4
• 500-	mA Typical Latch-Up Immunity at	GND 🛛 6 19 🛛 V _{CC}
125°		GND [] 7 18 [] V _{CC}
• Pack	age Options Include Plastic	
	II-Outline Packages, and Standard	A5 🛛 9 16 🗋 B6
	tic 300-mil DIPs	A6 🛛 10 15 🛛 B7
1 103		A7 [] 11 14 [] <u>B8</u>
descriptio	n	A8 🛛 12 13 🗍 OEBA

description

These octal bus transceivers are designed for asynchronous communication between data buses. The control function implementation allows for maximum flexibility in timing.

These devices transmit data from the A bus to the B bus or from the B bus to the A bus depending upon the level at the output-enable (OEAB or OEBA) inputs. The output-enable inputs can be used to disable the device so that the buses are effectively isolated.

The dual-enable configuration gives these devices the capability to store data by simultaneous enabling of OEAB and OEBA. Each output reinforces its input in this transceiver configuration. Thus, when both control inputs are enabled and all other data sources to the two sets of bus lines are at high impedance, both sets of bus lines (16 in all) will remain at their last states. The 8-bit codes appearing on the two sets of buses will be complementary for the 74AC11623.

The 74AC11623 is characterized for operation from -40°C to 85°C.

INP	UTS	OPERATION
OEBA	OEAB	OPERATION
L	L	B data to A bus
н	Н	A data to B bus
н	L	Isolation
L	Н	B data to A bus, A data to B bus

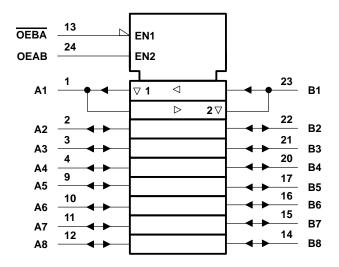
FUNCTION TABLE

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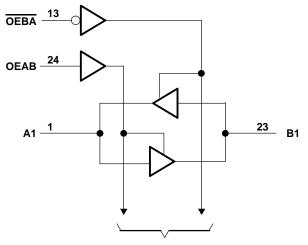
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logic symbol[†]



logic diagram (positive logic)



To 7 Other Channels

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage range, V _{CC}	−0.5 V to 7 V
Input voltage range, VI (see Note 1)	-0.5 V to V _{CC} + 0.5 V
Output voltage range, V _O (see Note 1)	-0.5 V to V _{CC} + 0.5 V
Input clamp current, I _{IK} (V _I < 0 or V _I > V _{CC})	
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND pins	±200 mA
Storage temperature range	−65°C to 150°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.



recommended operating conditions

			MIN	NOM	MAX	UNIT	
VCC	Supply voltage		3	5	5.5	V	
	High-level input voltage	$V_{CC} = 3 V$	2.1			V	
V_{IH}		$V_{CC} = 4.5 V$	3.15				
		V _{CC} = 5.5 V	3.85				
		$V_{CC} = 3 V$			0.9	V	
VIL	Low-level input voltage V	$V_{CC} = 4.5 V$			1.35		
		V _{CC} = 5.5 V			1.65		
VI	Input voltage		0		VCC	V	
VO	Output voltage		0		VCC	V	
		$V_{CC} = 3 V$			-4		
IOH	High-level output current	$V_{CC} = 4.5 V$			-24	mA	
		V _{CC} = 5.5 V			-24		
		V _{CC} = 3 V			12		
IOL	Low-level output current	V _{CC} = 4.5 V			24	mA	
	V _{CC} = 5				24		
$\Delta t/\Delta v$	Input transition rise or fall rate		0		10	ns/V	
Тд	Operating free-air temperature		-40		85	°C	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

П	ARAMETER	TEST CONDITIONS	N	T _A = 25°C			MIN	МАХ	UNIT
	ARAMETER		Vcc	MIN	TYP	MAX	WIIN	WAX	UNIT
			3 V	2.9			2.9		
		I _{OH} = – 50 μA	4.5 V	4.4			4.4		
			5.5 V	5.4			5.4		
Vон		$I_{OH} = -4 \text{ mA}$	3 V	2.58			2.48		V
			4.5 V	3.94			3.8		
		I _{OH} = – 24 mA	5.5 V	4.94			4.8		
		I _{OH} = -75 mA [†]	5.5 V				3.85		
			3 V			0.1		0.1	-
		I _{OL} = 50 μA	4.5 V			0.1		0.1	
						0.1		0.1	
VOL		I _{OL} = 12 mA	3 V			0.36		0.44	4
			4.5 V			0.36		0.44	
		I _{OL} = 24 mA	5.5 V			0.36		0.44	
		I _{OL} = 75 mA [†]	5.5 V				1.65		
lj	OEBA or OEAB	$V_{I} = V_{CC} \text{ or } GND$	5.5 V			±0.1		±1	μA
loz‡	A or B ports	$V_{O} = V_{CC} \text{ or } GND$	5.5 V			±0.5		±5	μA
ICC	-	$V_{I} = V_{CC} \text{ or GND},$ $I_{O} = 0$	5.5 V			8		80	μA
Ci	OEBA or OEAB	$V_I = V_{CC}$ or GND	5 V		4				pF
Cio	A or B ports	$V_{O} = V_{CC}$ or GND	5 V		12				pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

 \ddagger For I/O ports, the parameter I_{OZ} includes the input leakage current.



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switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	R FROM	то	T _A = 25°C			MIN	мах	UNIT
FARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX			UNIT
^t PLH	A or B	B or A	1.5	6.8	9.2	1.5	10.5	ns
^t PHL			1.5	6.3	8.2	1.5	9.3	
^t PZH	OEBA	A	1.5	8	10.6	1.5	12.2	ns
^t PZL			1.5	7.9	10.4	1.5	11.6	115
^t PHZ	OEBA	А	1.5	7	8.7	1.5	9.3	ns
^t PLZ		A	1.5	8	9.9	1.5	10.7	115
^t PZH	OEAB	В	1.5	8.2	10.4	1.5	12	ns
^t PZL	UEAD	в	1.5	8.3	10.8	1.5	12.2	115
^t PHZ	OEAB	В	1.5	7	8.8	1.5	9.4	ns
^t PLZ	OLAD	6	1.5	8	9.9	1.5	10.6	115

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

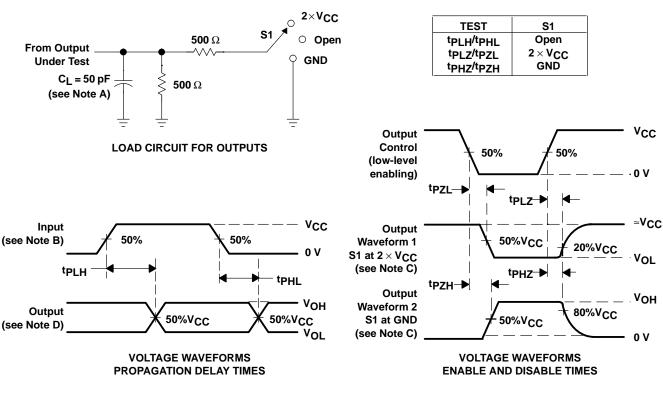
PARAMETER	FROM	то	T _A = 25°C			MIN	мах	UNIT
FARAIMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX		WAA	UNIT
tPLH	A or B	B or A	1.5	4.9	6.8	1.5	7.8	
tPHL		BUIA	1.5	4.6	6.4	1.5	7.1	ns
^t PZH	OEBA	A	1.5	5.8	7.9	1.5	9	ns
^t PZL			1.5	5.9	8.1	1.5	9.1	115
^t PHZ	OEBA	А	1.5	6.1	7.7	1.5	8.3	ns
^t PLZ		A	1.5	6.6	8.2	1.5	8.8	115
^t PZH	OEAB	В	1.5	6.2	8	1.5	9.2	2
^t PZL	OEAB	D	1.5	6.1	8.3	1.5	9.4	ns
^t PHZ	OEAB	В	1.5	6.2	7.8	1.5	8.3	ns
^t PLZ	OLAB	0	1.5	6.5	8.1	1.5	8.8	115

operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER			TEST CO	TYP	UNIT	
C _{pd} Power dissipation cap	Dower discipation conscitutes per transcriver	Outputs enabled	C _L = 50 pF, f = 1 MHz		49	ъЕ
	Power dissipation capacitance per transceiver	Outputs disabled		9	pF	



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 3 ns. t_f \leq 3 ns. For testing pulse duration: t_f = t_f = 1 to 3 ns. Pulse polarity can be either high-to-low-to-high or low-to-high-to-low.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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